UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant:

Van Ginneken

Docket No: 054355/0309380

Serial No:

New

MAG-001-C2

Filed:

Herewith

April 19, 2004

For:

Timing Closure Methodology

MAIL STOP PATENT APPLICATIONS Commissioner of Patents P.O. Box 1450 Alexandria, VA 22313

INFORMATION DISCLOSURE STATEMENT

Applicant submits herewith patents, publications or other information of which Applicant is aware which are believed to be material to the examination of this application and in respect of which there may be a duty to disclose in accordance with 37 CFR 1.56.

The filing of this information disclosure statement shall not be construed as a representation that a search has been made (37 CFR 1.97(g)), nor as an admission that the information cited is, or is considered to be, material to patentability, nor an admission that no other material information exists. The filing of this information disclosure statement shall not be construed as an admission against interest in any manner.

This Information Disclosure Statement is being filed with a new application. The references cited herein were cited in the parent application Serial No. 10/134,076 filed April 24, 2002, and therefore copies of the references are not included. No additional fee is due.

> Respectfully submitted PILLSBURY WINTHROP LLP

REPLY TO CUSTOMER NO. 27498

INFORM	ATION DISCLOS PTO-1449		Atty Docket 054355/0039380		Serial No.				
				Applicant Van G	Sinneken				
				Filing Date April 19, 2004		Group Art Unit			
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in

INFORMATION DISCLOSURE CITATION PTO-1449				Atty Docket 054355/0039380		Serial No.		
				Applicant Van Ginneken				
		Filing Date April 19, 2004		Group Art Unit				
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Van Ginneken

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